Se	arch	Note	es	

Application/Control No.	Applicant(s)/Patent under Reexamination
09/454,941	KIRK, DAVID B.
Examiner	Art Unit
Harold Kim	2181

SEARCHED				
Class	Subclass	Date	Examiner	
710	52, 305, 57, 59	7/22/2007	нк	
370	378	7/22/2007	нк	
345	501	7/22/2007	нк	
700	108	8/30/2007	нк	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
710	52, 305	7/22/2007	нк	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPAT, USPGPUB, JPO, EPO, IEEE, NPL, EAST, see attached search note; inventor search on eDan	7/22/2007	нк		